

Search Notes

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Examiner

Sy D. Luu

Applicant(s)/Patent under
Reexamination

NEWELL ET AL.

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	760,853, 854	8/7/2006	SL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
US-PGPUB		11/9/2006	SL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT US-PGPUB	8/7/2006	SL
Text Searches: 715/760,733,741,743-747,810,851- 855,705,712-713,961,962,700 715/501.1,513 705/1,8	8/7/2006	SL
PLUS	7/27/2006	SL
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